

## **Search Notes**



**Application/Control No.**

10/721,518

Examiner

Matthew J. Kasztejna

**Applicant(s)/Patent under  
Reexamination**

YAMAYA ET AL.

## **Art Unit**

3739

**SEARCHED**

**SEARCH NOTES  
(INCLUDING SEARCH STRATEGY)**

## **INTERFERENCE SEARCHED**

INTERFERENCE SEARCHED			
Class	Subclass	Date	Examiner